Notice of References Cited Application/Control No. 10/743,726 Examiner Lee Lum Applicant(s)/Patent Under Reexamination TANAKA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,447,271	09-2002	Ojima et al.	417/410.4
	В	US-6,044,723	04-2000	Eda et al.	74/388PS
	С	US-6,561,306	05-2003	Watanabe et al.	180/444
	D	US-6,763,738	07-2004	Tsutsui et al.	74/388PS
	E	US-6,523,431	02-2003	Ozsoylu et al.	74/443
	F	US-5,360,322	11-1994	Henein et al.	417/313
	G	US-		·	
	Н	US-			
	- 1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.